SHEE	T <u>1</u>	OF
TION NO.		

INFORMATION DISCLOSURE CITATION CUSTOMER NUMBER ATTORNEY'S DKT NO. H1105D Applicant(s) APPLICATION No. 10/602,061

}

Shibly S. Ahmed et al.

GROUP

2812 June 24, 2003 45114 PTO-1449 U.S. PATENT DOCUMENTS FILING DATE SUBCLASS CLASS NAME EXAMINER'S DATE PATENT NO. INITIALS 192 438 Adkisson et al. 10/2002 6,472,258 FOREIGN PATENT DOCUMENTS Translation SUBCLASS No CLASS EXAMINER'S INITIALS COUNTRY DATE PATENT NO. OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) DATE CONSIDERED **EXAMINER**

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

INFORMATION Customer Number 26615 CITATION PTO-1449 U.S. PATENT DOC			ATTORNEY'S DKT NO. APPLICATION NO. 10/602,061 APPLICANT(S) Shibly S. AHMED et al. FILING DATE June 24, 2003 MENTS APPLICATION NO. 10/602,061 APPLICATION NO. 10/602,061						
EV ANIIVEDIS		Γ				Ι	FILIN	lG	
EXAMINER'S INITIALS	PATENT NO.	DATE	NAMI		CLASS	SUBCLASS	DAT	TE	
BP	5,563,082	10-08-96	Mukai		437	41	12-23	-94	
RP	6,413,802 B1	07-02-02	Hu et al.		438	151	10-23-00		
					<u> </u>				
		•							
		1						·	
FOREIGN PATENT DOCUMENTS									
EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY		CLASS	SUBCLASS	Trans! Yes	ation No	
INITIALS	PATERT NO.	<u> </u>							
					-				
					-				
			<u> </u>		1.				
	<u> </u>		<u> </u>		<u> </u>	<u> </u>	ــــــــــــــــــــــــــــــــــــــ	L	
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.) Leland Chang et al.: "Gate Length Scaling and Threshold Voltage Control of Double-Gate									
RP	MOSFETs," IEDM, December 10, 2000, pages 719-722.								
				· · · · · · · · · · · · · · · · · · ·		· · · · · · · · · · · · · · · · · · ·			

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

EXAMINER

DATE CONSIDERED

4-26-05